


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580052	<b>Applicant(s)/Patent Under Reexamination</b>  AKASHI ET AL.
	<b>Examiner</b>  Dawn L. Garrett	<b>Art Unit</b>  1794

### SEARCHED

Class	Subclass	Date	Examiner
428	690, 917 (see EAST history for all listed class/subclasses)	9-23-2008	DG
313	504, 506	9-23-2008	DG
257	40, E51.051	9-23-2008	DG
564	434	9-23-2008	DG

### SEARCH NOTES

Search Notes	Date	Examiner
STIC structure search by EIC 1700 (M. Huang) (see attached printouts)	9-23-2008 and 9-24-2008	DG
STN search of registry numbers (see attached)	9-23-2008	DG
EAST search (see printout); Databases: EPO, JPO, DERWENT, USPAT, USPGPUB	9-23-2008 and 9-24-2008	DG
Inventor Name Search	9-23-2008	DG
reviewed prior STIC search printouts in application file	5-15-2009	DG
updated Inventor Name Search	5-15-2009	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5-15-2009	DG
updated Inventor Name Search	8-17-2009	DG
updated EAST search (see Prior Art search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	8-17-2009	DG
Consulted S.P.E. Larry Tarazano regarding amendment to the specification filed 7/28/09	8-13-2009	DG

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference search done in EAST in USPGPUB and UPAD databases, keywords searched in claim field (see Interference Search history printout)	5-15-2009 and 8-17-2009	DG

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